# **Online Data Processing and Hit Time Reconstruction** for Silicon Detector Readout BELLE



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A major upgrade of the KEKB factory (Tsukuba, Japan) is foreseen until 2013, aiming at a luminosity of up to 8 x  $10^{35}$  cm<sup>-2</sup>s<sup>-1</sup>, which is about 40 times the present value. Accordingly, a similar increase is expected for trigger rate and occupancy of the Silicon Vertex Detector (SVD). The current readout system has a shaping time of 800 ns, no multi-event memory and thus requires a trigger within this period. As it already operates at its limit, it obviously has to be replaced for the upgrade.

We developed a readout system using the APV25 chip with a shorter shaping time of 50 ns, 40 MHz readout and an integrated 192 cell deep analog pipeline. By taking six consecutive samples of the shaper output and processing these data with FPGAs on a VME module we can determine timing information of the hits with a precision of about 3 ns RMS, depending on the signal-to-noise ratio. Both the short shaping time and the hit time finding lead to a significant occupancy reduction and thus ease subsequent track finding. Thanks to reading several samples the system can tolerate a trigger jitter of up to +/-2 clocks.

A dedicated pipelined data processor is implemented for each input, which performs strip reordering, pedestal subtraction, a two-pass common mode correction and zero suppression. It finally encodes position, pulse height and time information of a hit in a single 32 bit word. The acceptable trigger rate is up to 50 kHz, limited by the time needed to read out 6 samples from the APV25.



### **APV25 Front-End Chip**



10 bit ADC

16 input channels

Hit time reconstruction

64 bit, 40 MHz local bus

**PROCESS** 

FADC

#### FADC + PROCESSOR Features

Transparent mode (pedestal determination)

Processed mode (optional w/o time finding)

Data processing & zero suppression





### Front-end:

Flexible Circuit with thinned APV25 chips using the Chip-on-Sensor concept for low material budget.



## **Dock-box:**

Motherboard (Mambo) with up to 6 Repeater boards (Rebo) for signal level translation, signal buffering, power monitoring and overvoltage protection.

![](_page_0_Figure_21.jpeg)

![](_page_0_Figure_22.jpeg)

![](_page_0_Figure_23.jpeg)

The FADC+PROCESSOR is a 9U VME board with 16 input channels used to digitize and process the data of the APV25 chips. The core functions are implemented in FPGAs and thus can easily be adapted by modifying the firmware.

A dedicated data processing chain is forseen for each input, performing APV25 header detection, strip reordering, a two-pass common mode correction, zero suppression and hit time reconstruction (see below). Finally position, pulse height and timing information of a hit are encoded in a single 32 bit wide word.

Thanks to the pipelined design with several FIFOs and a 64 bit wide local bus, data can be processed continously as long as they are fetched by the downstream DAQ system without congestion. Thus the acceptable trigger rate is about 50 kHz, limited by the time needed to read out the samples from the APV25 chips.

### Advantage:

The sensitive time window and thus the occupancy depends on the shaping time ( $T_{\rm o}$ ) of the front-end chip. Hence, a gain of ~12.5 can be achieved by using the APV25 instead of the VA1TA. However, knowing the timing information of the hits, an additional reduction of the sensive time window by a factor of  $\sim 8$  is possible. The knowledge of the correct timing further allows to match hits across layers and reject off-time background in the offline analysis.

![](_page_0_Figure_29.jpeg)

![](_page_0_Picture_30.jpeg)

### **Back-end:**

VME controller board (Neco) for trigger and control signals.

FADC boards with online data processing using FPGAs.

**Data acqusition** 

	•	00	1100	100	200	200	000
Method:			t <sub>peak</sub>			Т	ime [ns]

The multi-peak mode of the APV25 allows to take 3, 6, 9, ... consecutive samples of the shaper output signal. Three points around the maximum of the curve can be used to determine timing and amplitude of the peak with lookup tables, which are generated from the calibration pulse of the APV25.

Thanks to using only three out of six samples, a trigger jitter of up to +/-2 clocks can be tolerated.

A time resolution of 2 ... 3 ns RMS can be achieved with this method, depending on the signal-to-noise ratio (SNR).

### Beam test setup:

LIS The readout system was tested in several beam tests at KEK and CERN together with four DSSD modules, which are all prototypes for the SuperSVD equipped with APV25 chips.

![](_page_0_Picture_41.jpeg)

![](_page_0_Figure_42.jpeg)

![](_page_0_Figure_43.jpeg)

### http://www.hephy.at

![](_page_0_Picture_46.jpeg)